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**PATENT** 



Docket No.: 065933-0067

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277

Isao HASEGAWA, et al. : Confirmation Number: 2729

Application No.: 10/796,189 : Group Art Unit: 2821

Filed: March 10, 2004 : Examiner: S. Roy

For: WIRING STRUCTURE FORMED IN CONTACT HOLE, MANUFACTURING METHOD THEREFOR, AND A DISPLAY APPARATUS HAVING THE SAME (AS AMENDED)

## INFORMATION DISCLOSURE STATEMENT

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed more than three months after the U.S. filing date AND after the mailing date of the first Office Action on the merits, but before the mailing date of a Final Rejection or Notice of Allowance.

## **CERTIFICATION PARAGRAPH**

The undersigned certifies that the two Japanese Office Actions were received in communications from a foreign patent office in a counterpart foreign application for related

application 10/383,058 not more than three months prior to the filing of this Information Disclosure Statement as described in 37 CFR 1.97(e)(1).

JP 2000-349298, JP 2000-277607, JP 8-306693, JP 09-312292, and JP 01-289140 were cited in an office action for a counterpart foreign application for related application 10/383,058 and their relevance discussed therein. A copy of the Japanese office action, together with an English language version thereof, is attached for the Examiner's information. JP 2000-349298 and JP 2000-277607 were cited in Information Disclosure Statements of July 12, 2004 and August 17, 2004, respectively, and are not attached.

JP 09-148586, JP 02-39536, and JP 02-39536 were cited in a corresponding foreign application search report or office action counterpart foreign application for related application 10/383,058 and their relevance discussed therein. A copy of the Japanese office action, together with an English language version thereof, is attached for the Examiner's information. JP 02-39536 was cited in an Information Disclosure Statement of July 12, 2004 and is not attached.

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

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Facsimile: 202.756.8087 **Date: April 25, 2005** 

Please recognize our Customer No. 20277 as our correspondence address.

SHEET 1 OF 1

APPLICANT   Isao HASEGAWA, et al.				
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U.S. PATENT DOCUMENTS				
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)				
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.